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Contents

	PHASE SHIFTING ALGORITHMS
11490 03	A comprehensive review of the principal component analysis applied to the demodulation of phase-shifting interferograms [11490-1]
11490 04	Windowed generalized phase-shifting algorithms [11490-2]
11490 06	Suppressing ripple distortions and spurious pistons in phase-shifting interferometry [11490-4]
	TECHNIQUES
11490 07	A fringe career (Invited Paper) [11490-5]
11490 08	Hybrid calibration method for improving 3D measurement accuracy of structured light systems [11490-6]
11490 09	Numerical integration of slope data with application to deflectometry [11490-7]
	METROLOGY FOR DYNAMIC APPLICATIONS
11490 OA	Air Force Research Laboratory, Aero-Effects Laboratory optical metrology system and performance (Invited Paper) [11490-8]
11490 OD	Machine-learning based fast unsupervised variational image decomposition for fringe pattern analysis [11490-11]
11490 OE	Predictive modeling of wavefront error using dynamic mode decomposition [11490-12]
	CHARACTERIZATION
11490 OG	Reproducibility of two calibration procedures for phase-measuring deflectometry [11490-14]
11490 OH	Performance specification of areal surface texture instruments exemplified by a self-built WLI [11490-15]

SHAPE MEASUREMENT

	SHAFE MEASUREMENT
11490 OJ	Photomechanics evaluation combining fringe projection and digital height correlation (Invited Paper) [11490-17]
11490 OK	Cascade optical coherence tomography (C-OCT) towards freeform metrology [11490-18]
11490 OL	Autofocus methods for 3D shape measurement with digital fringe projection techniques [11490-19]
	HOLOGRAPHIC TECHNIQUES
11490 ON	A new digital holographic microscope for the study of biological systems (Invited Paper) [11490-21]
	NON-DESTRUCTIVE TECHNIQUES
11490 OR	Use of Moiré fringes in digital holography for optical alignment [11490-25]
11490 OS	Underwater shearography – considerations and first results [11490-26]
	INSTRUMENT RESPONSE/CHARACTERIZATION
11490 OT	Fourier optics modelling of instrument response for interference microscopy (Invited Paper) [11490-27]
11490 OU	A star-test wavefront sensor using neural network analysis [11490-28]
11490 OV	Amplitude edge response characterization of interferometer ITF and the effect of defocus [11490-29]
11490 OW	Binary pseudorandom array test standard optimized for characterization of large field-of-view optical interferometers [11490-30]
	ON THE FRINGE
11490 OX	Betelgeuse scope: single-mode-fibers-assisted optical interferometer design for dedicated stellar activity monitoring [11490-31]
11490 OY	Quantitative phase imaging using azobenzene liquid crystal [11490-32]

POSTER SESSION

11490 10	Surface form characterization of plane-parallel elements using frequency-tuned phase-shifting interferometry [11490-34]
11490 11	Tunable phase shifting algorithm insensitive to phase-step miscalibration [11490-35]
11490 12	Development of a phase shifting interferometer using recycled components [11490-36]
11490 13	Monitoring of PpIX-induced death dynamics in HeLa cells by digital holographic tomography [11490-215]